

M35500AFP/BGP

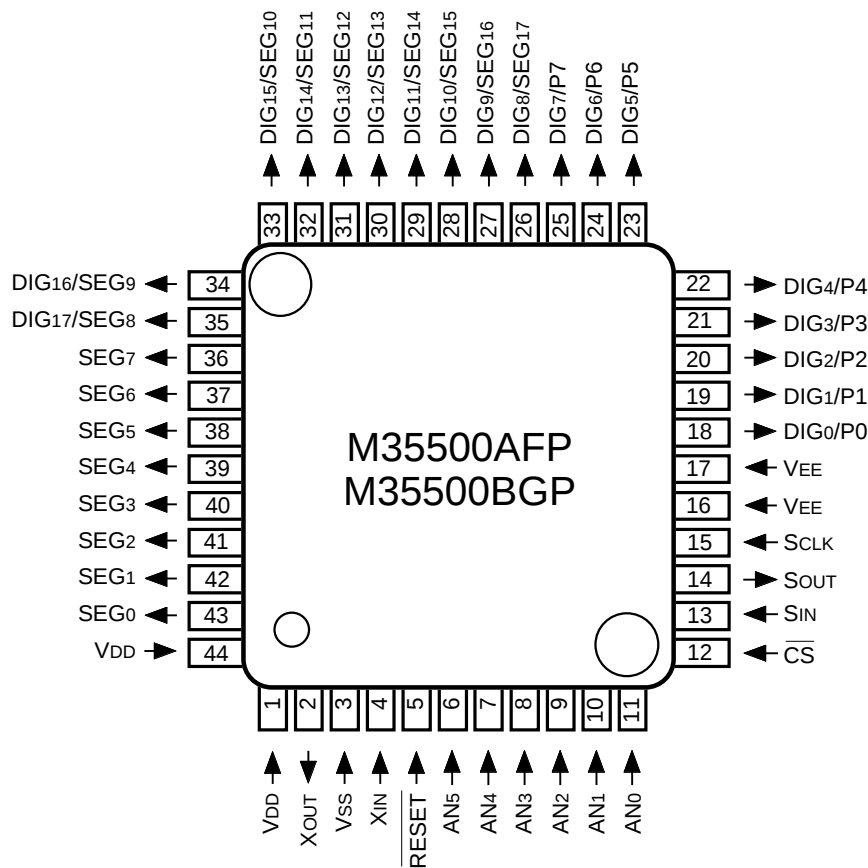
FLD(VFD) CONTROLLER

DESCRIPTION/FEATURES

- High-breakdown-voltage output port 26
 - Segment output 8 to 18
 - Digit output 7 to 10
(Ports P0 to P7 are also used as ordinary output ports)
 - Output breakdown Vcc – 45 V
 - Output current –18 mA (DIG0 to DIG17),
–7 mA (SEG0 to SEG7)
 - Pull-down resistor build-in
 - Dimmer switch 4 levels
- A-D converter 8-bit X 6 channels
 - Absolute accuracy ±3 LSB

- Serial I/O 4 (CS controller, external clock)
 - Noise filter build-in
(in serial input pin and clock pin, 2 MHz sampling)
 - FLD display data input
 - A-D conversion data output
 - Command input
- Package 44P6N/44P6X
- Oscillating circuit RC oscillating circuit (external capacitor)
 - Oscillating frequency 4 MHz
- Power source voltage 4.0 to 5.5 V

PIN CONFIGURATION (TOP VIEW)



Package type: 44P6N-A/44P6X

Fig. 1. Pin configuration of M35500AFP/BGP

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PIN DESCRIPTION

Table. 1. Pin description

Pin	Name	Input	Output	Function
VCC, VSS	Power source			• Apply voltage of 5 V to Vcc, and 0 V to Vss.
VEE	Pull-down power source			• Applies voltage supplied to pull-down resistors.
XIN	Clock input	Input		• RC oscillator pins for system clock.
XOUT	Clock output		Output	
RESET	RESET input	CMOS input		• Reset input pin for active "L". • Internal pull-up resistors connected between the RESET and Vcc pins.
CS	Chip select	CMOS input		• Serial transfer is possible by inputting "L" signal.
SCLK	Serial clock	CMOS input Noise filter		• Clock for serial transfer is input. • Read a clock twice with 2 MHz sampling clock and judge if it is a noise or not.
SOUT	Serial output		N-channel open-drain	• Serial data is output. • During reset it is in high-impedance state.
SIN	Serial input	CMOS input Noise filter		• Serial data is input. • Read a clock twice with 2 MHz sampling clock and judge if it is a noise or not.
DIG0/P0 – DIG7/P7	Digit/Port		P-channel open-drain	• Pin for ordinary output or digit output. • At reset this port is set to VEE level through a pull-down resistor.
DIG8/SEG17 – DIG17/SEG8	Digit/Segment		P-channel open-drain	• Pin for digit output or segment output. • At reset this port is set to VEE level through a pull-down resistor.
SEG0 – SEG7	Segment		P-channel open-drain	• Pin for segment output. • At reset this port is set to VEE level through a pull-down resistor.

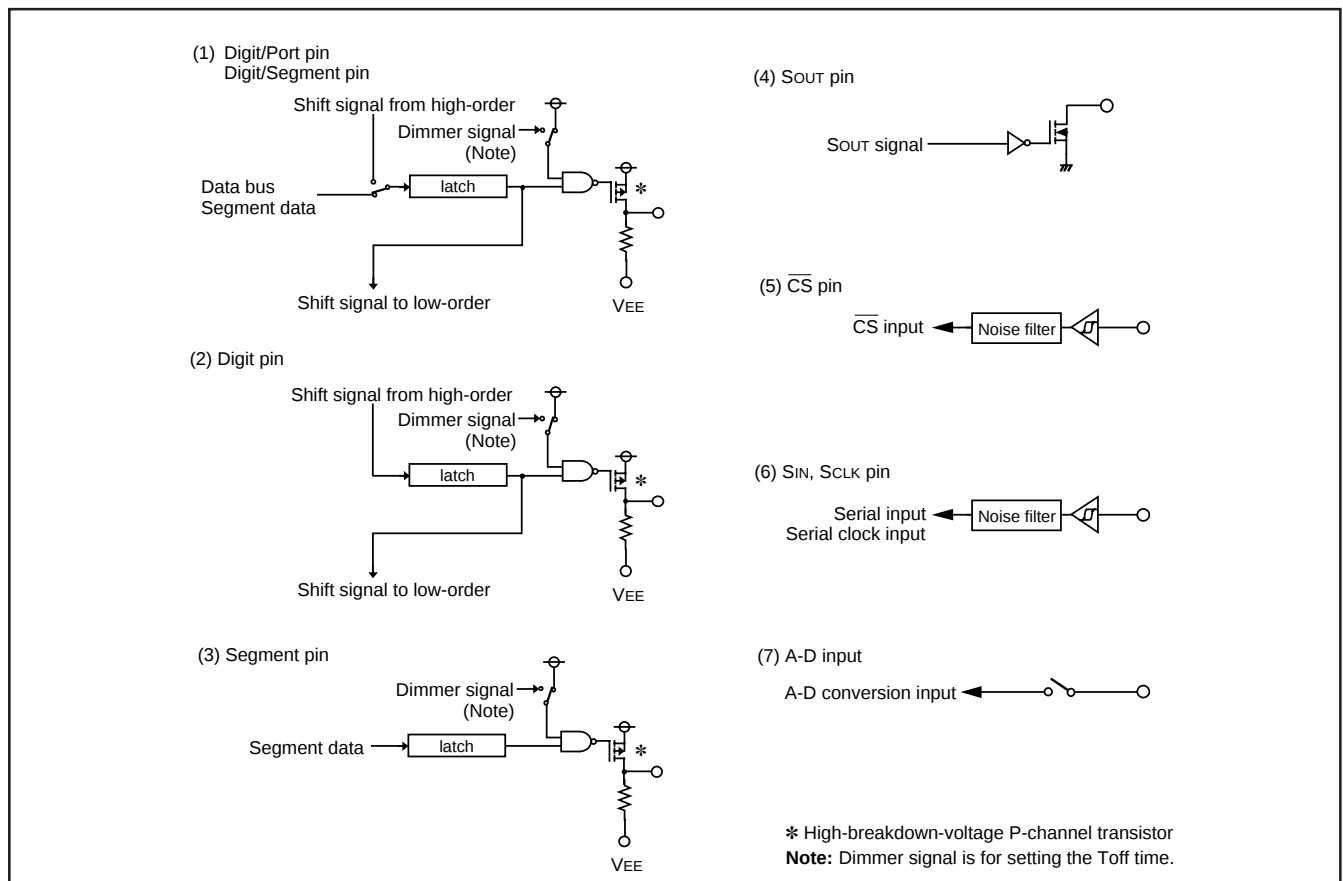
PORT BLOCK

Fig. 3. Port block diagram

COMMAND STYLE

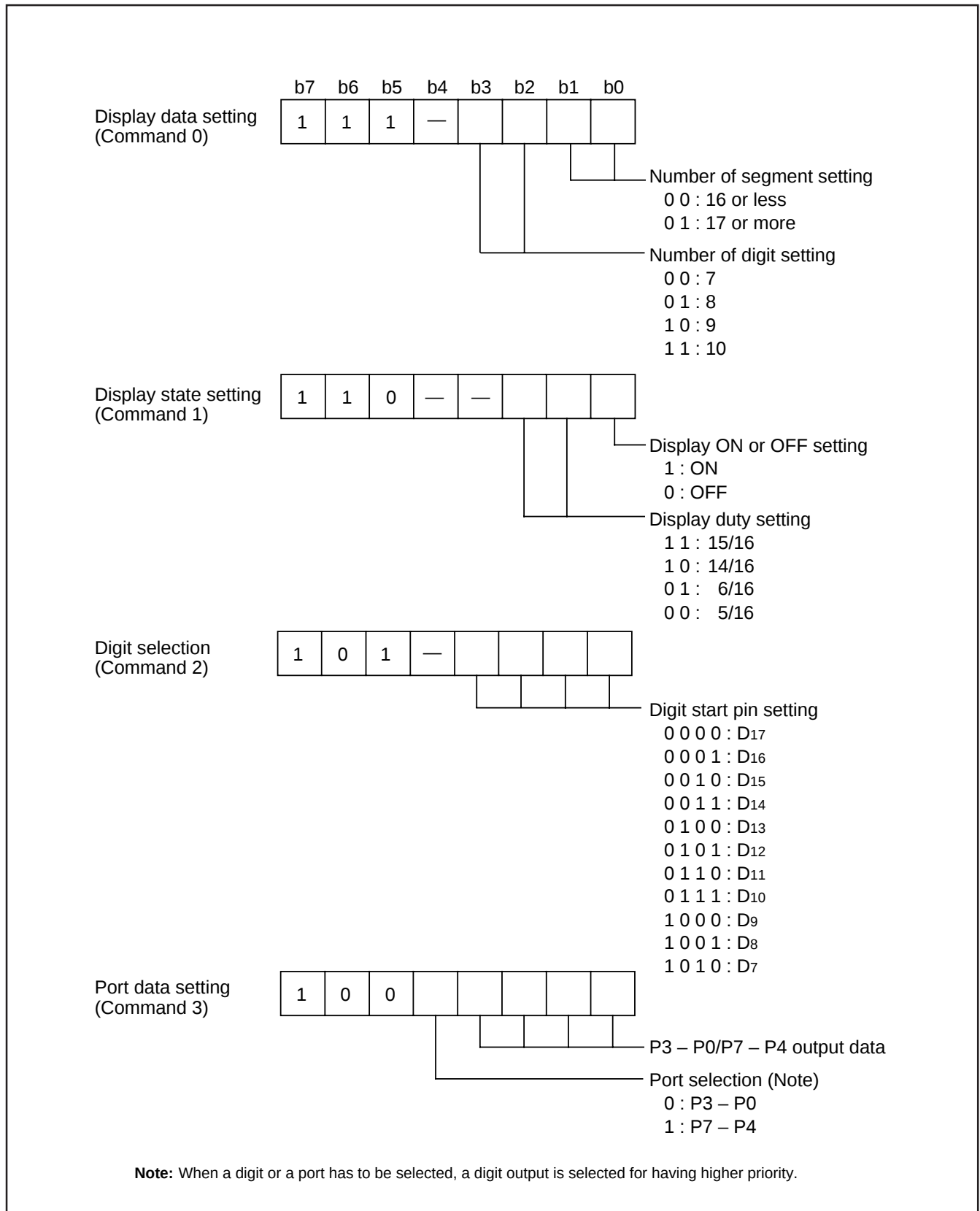
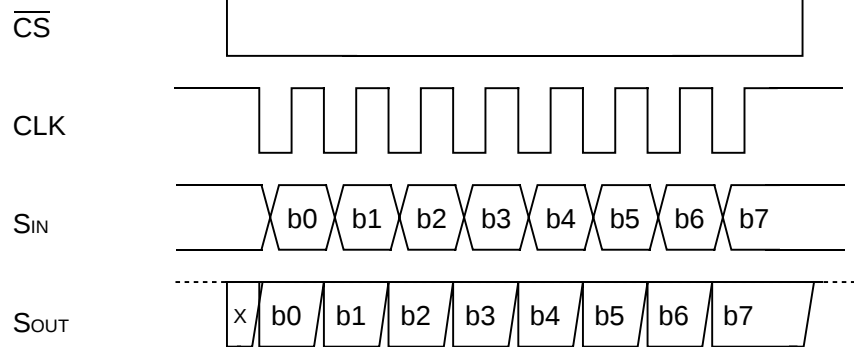
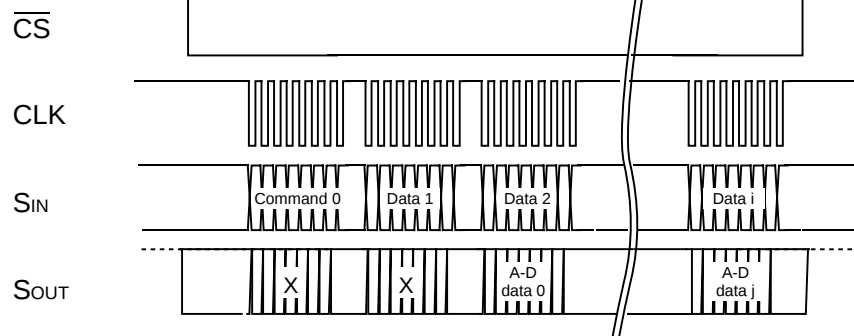


Fig. 4. Command style

SERIAL I/O PROTOCOL
Byte protocol


Note: SOUT is in high-impedance state during CS signal is "H".

Command protocol
**Display data setting
(Command 0)**


Note 1: The serial data which is transmitted after executing command 0 is recognized as a display data.

"A-D data 6 or more" data is defined as an undefined "X".

Note 2: Set the CS signal to "H" level after transferring a display data.

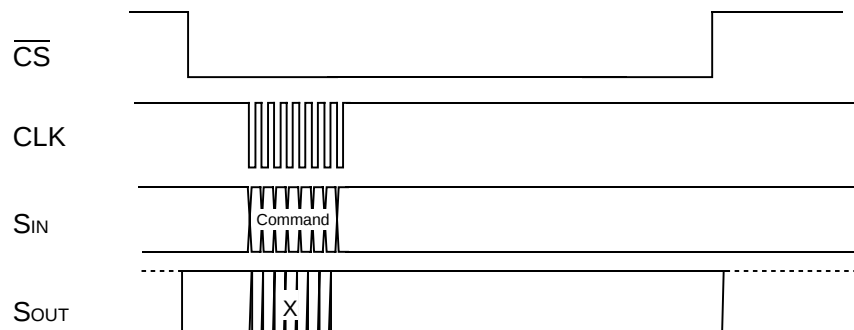
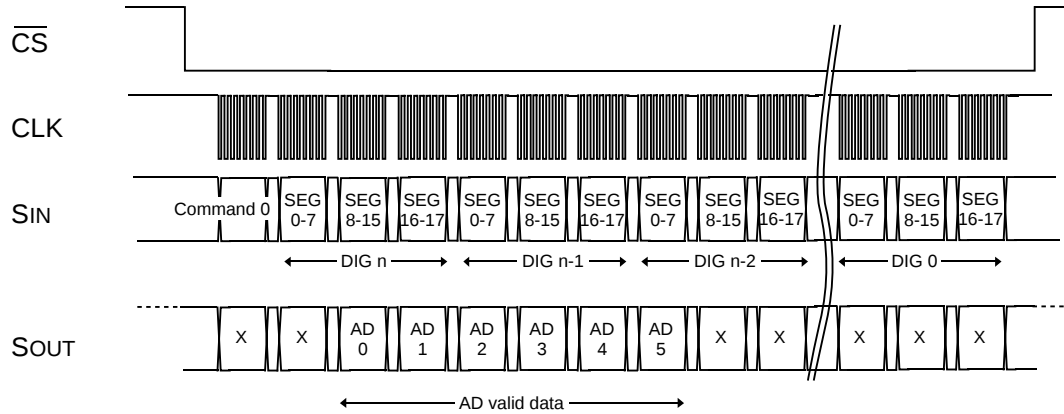
**Other setting except
display data setting
(Command 1 to 3)**


Fig. 5. Serial I/O protocol

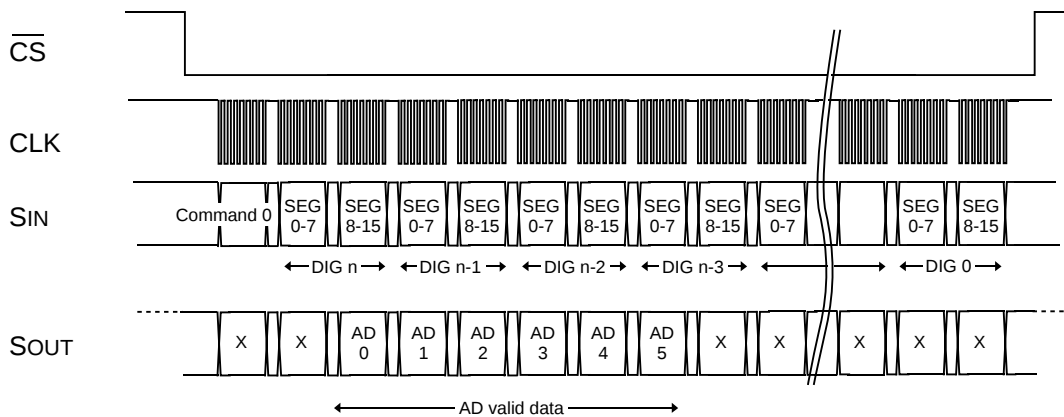
SERIAL COMMUNICATION FORMAT (DISPLAY DATA, A-D OUTPUT)

17 or more segments (3-byte transfer)



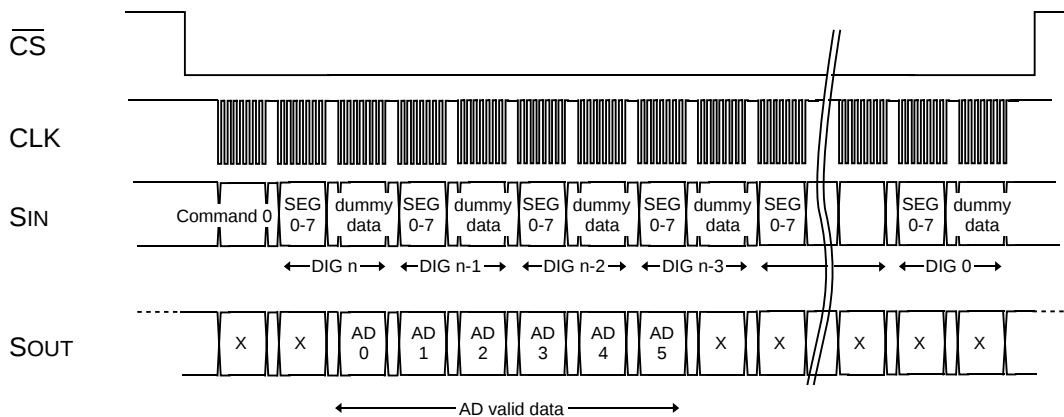
Note: 2 bytes "X" data is output before outputting AD valid data.

16 or less segments (2-byte transfer)



Note: 2 bytes "X" data is output before outputting AD valid data.

8 or less segments (2-byte transfer)



Note: 2 bytes "X" data is output before outputting AD valid data.

Fig. 6. Serial communication format

FLD DISPLAY TIMING

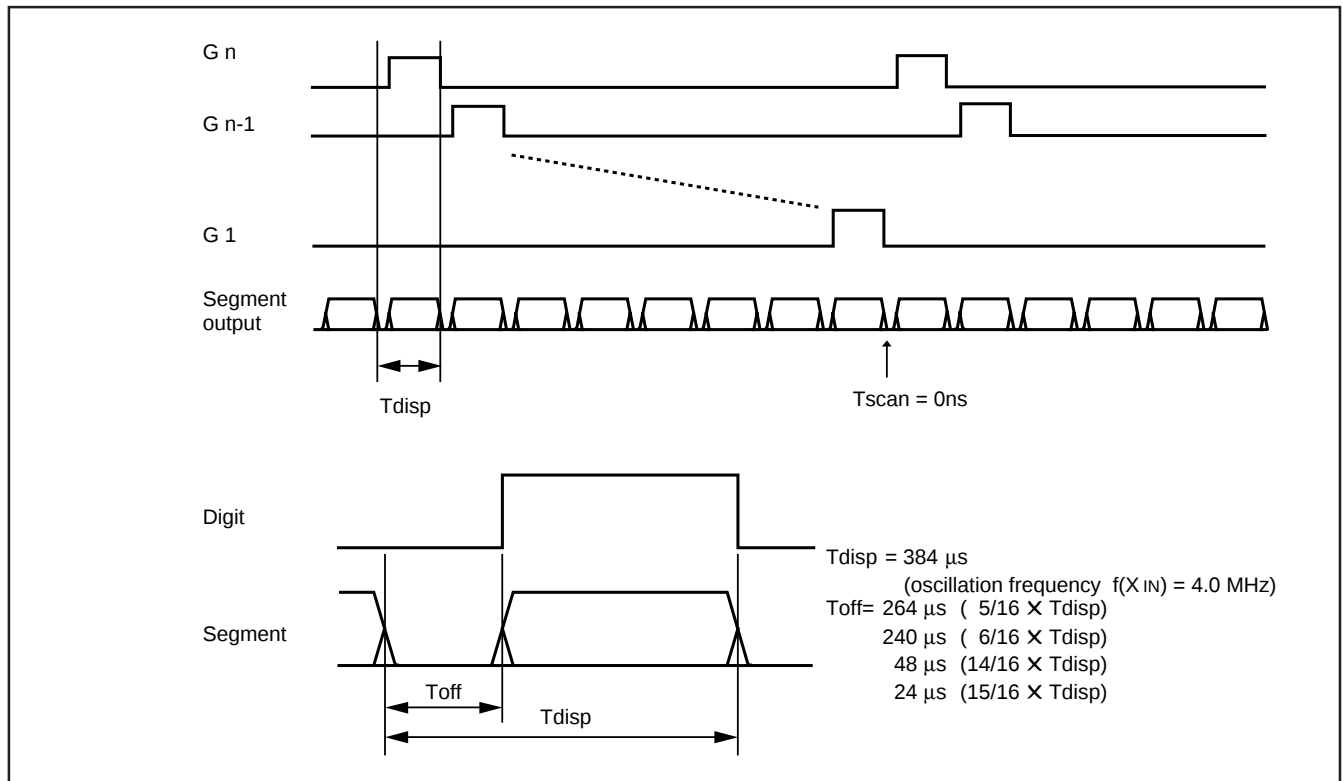


Fig. 7. FLD display timing diagram

SEGMENT/DIGIT SETTING EXAMPLE

	PORT	DIG	SEG	Grid : 7 Segment : 8	Grid : 10 Segment : 8	Grid : 10 Segment : 16	Grid : 7 Segment : 18
1			SEG0	S1	S1	S1	S1
2			SEG1	S2	S2	S2	S2
3			SEG2	S3	S3	S3	S3
4			SEG3	S4	S4	S4	S4
5			SEG4	S5	S5	S5	S5
6			SEG5	S6	S6	S6	S6
7			SEG6	S7	S7	S7	S7
8			SEG7	S8	S8	S8	S8
9		DIG17	SEG8	G7	G10	S9	S9
10		DIG16	SEG9	G6	G9	S10	S10
11		DIG15	SEG10	G5	G8	S11	S11
12		DIG14	SEG11	G4	G7	S12	S12
13		DIG13	SEG12	G3	G6	S13	S13
14		DIG12	SEG13	G2	G5	S14	S14
15		DIG11	SEG14	G1	G4	S15	S15
16		DIG10	SEG15		G3	S16	S16
17		DIG9	SEG16		G2	G10	S17
18		DIG8	SEG17		G1	G9	S18
19	P7	DIG7				G8	G7
20	P6	DIG6				G7	G6
21	P5	DIG5				G6	G5
22	P4	DIG4				G5	G4
23	P3	DIG3				G4	G3
24	P2	DIG2				G3	G2
25	P1	DIG1				G2	G1
26	P0	DIG0				G1	

Fig. 8. Segment/Digit setting example

BIT ALLOCATION FOR DISPLAY RAM

ADDRESS	b7						b0		
09 ₁₆							SEG 17	SEG 16	Digit0
0A ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
0B ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
0D ₁₆							SEG 17	SEG 16	Digit1
0E ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
0F ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
11 ₁₆							SEG 17	SEG 16	Digit2
12 ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
13 ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
15 ₁₆							SEG 17	SEG 16	Digit3
16 ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
17 ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
19 ₁₆							SEG 17	SEG 16	Digit4
1A ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
1B ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
1D ₁₆							SEG 17	SEG 16	Digit5
1E ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
1F ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
21 ₁₆							SEG 17	SEG 16	Digit6
22 ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
23 ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
25 ₁₆							SEG 17	SEG 16	Digit7
26 ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
27 ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
29 ₁₆							SEG 17	SEG 16	Digit8
2A ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
2B ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	
2D ₁₆							SEG 17	SEG 16	Digit9
2E ₁₆	SEG 15	SEG 14	SEG 13	SEG 12	SEG 11	SEG 10	SEG 9	SEG 8	
2F ₁₆	SEG 7	SEG 6	SEG 5	SEG 4	SEG 3	SEG 2	SEG 1	SEG 0	

Fig. 9. Bit allocation for display RAM

RESET CIRCUIT

To reset the controller, the $\overline{\text{RESET}}$ pin should be held at a “L” level for 2 μs or more. Then the $\overline{\text{RESET}}$ pin is returned to an “H” level (the power source voltage should be between 4.0 V and 5.5 V, and XIN oscillation is stable), reset is released. Make sure that the reset input voltage is 0.5 V or less for 4.0 V of Vcc .

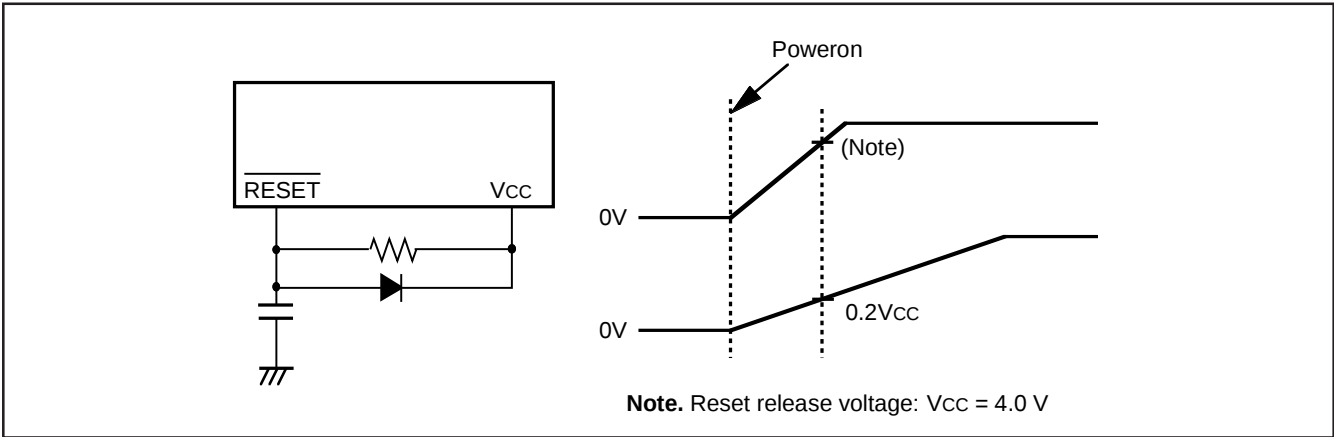


Fig. 10. Reset circuit example

CLOCK GENERATING CIRCUIT

Oscillating circuit is built up by connecting pins XIN and XOUT as short as possible and connecting a capacitor between pins XIN (XOUT) and Vss . When supplying a clock externally, input it to XIN pin and leave XOUT pin open.

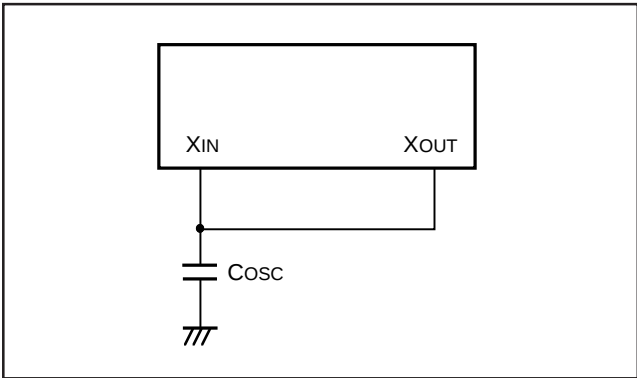


Fig. 11. RC generating circuit

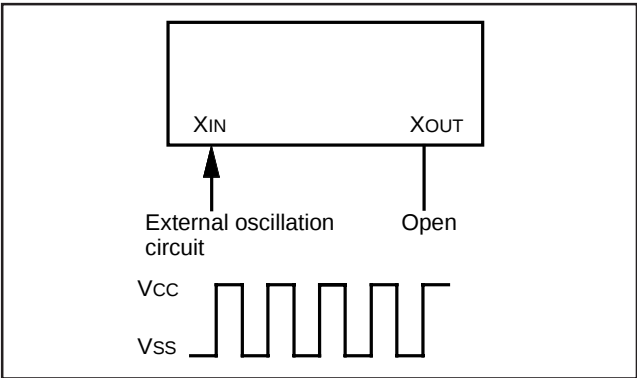


Fig. 12. External clock input circuit

HANDLING OF UNUSED PINS

Handle unused pins as the follow.

Table. 2. Handling of unused pins

Pin	Handling
Segment	Open
Digit	Open
Analog input	Connect to Vcc or Vss through a resistor.

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC}	Power source voltage	• All voltage are based on V_{SS}. • Output transistors are cut off.	−0.3 to 7.0	V
V _{EE}	Pull-down power source voltage		V _{CC} −45 to V _{CC} +0.3	V
V _I	Input voltage AN ₀ – AN ₅		−0.3 to V _{CC} +0.3	V
V _I	Input voltage CS, S _{IN} , S _{CLK}		−0.3 to V _{CC} +0.3	V
V _I	Input voltage RESET		−0.3 to V _{CC} +0.3	V
V _O	Output voltage DIG ₀ – DIG ₁₇ SEG ₀ – SEG ₁₇	• All voltage are based on V_{SS}. • Output transistors are cut off. • A waveform: 450 μs or more frequency and 30 μs or less pulse width. • Connect only capacitor load (C_L = 200pF).	V _{CC} −45 to V _{CC} +0.3	V
			V _{CC} −50 to V _{CC} +0.3	
V _O	Output voltage S _{OUT}	• All voltage are based on V_{SS}. • Output transistors are cut off.	−0.3 to V _{CC} +0.3	V
P _d	Power dissipation	T _a = 25 °C	600	mW
T _{opr}	Operating temperature		−20 to 85	°C
T _{stg}	Storage temperature		−40 to 125	°C

RECOMMENDED OPERATING CONDITIONS (V_{CC} = 4.0 to 5.5 V, T_a = −20 to 85 °C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min.	Typ.	Max.	
V _{CC}	Power source voltage	4.0	5.0	5.5	V
V _{SS}	Power source voltage		0		V
V _{EE}	Pull-down power source voltage	V _{CC} −38		V _{CC}	V
V _{IH}	“H” input voltage CS, S _{IN} , S _{CLK}	0.75V _{CC}		V _{CC}	V
V _{IH}	“H” input voltage RESET	0.8V _{CC}		V _{CC}	V
V _{IL}	“L” input voltage CS, S _{IN} , S _{CLK}	0		0.25V _{CC}	V
V _{IL}	“L” input voltage RESET	0		0.2V _{CC}	V

RECOMMENDED OPERATING CONDITIONS (V_{CC} = 4.0 to 5.5 V, T_a = −20 to 85 °C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min.	Typ.	Max.	
ΣI _{OH} (peak)	“H” total peak output current DIG ₀ – DIG ₁₇ , SEG ₀ – SEG ₁₇ (Note 1)			−240	mA
ΣI _{OH} (avg)	“H” total peak output current DIG ₀ – DIG ₁₇ , SEG ₀ – SEG ₁₇			−120	mA
I _{OH} (peak)	“H” peak output current DIG ₀ – DIG ₁₇ (Note 2)			−40	mA
I _{OH} (peak)	“H” peak output current SEG ₀ – SEG ₇ (Note 2)			−20	mA
I _{OL} (peak)	“L” peak output current S _{OUT}			10	mA
I _{OH} (avg)	“H” peak output current DIG ₀ – DIG ₁₇ (Note 3)			−18	mA
I _{OH} (avg)	“H” peak output current SEG ₀ – SEG ₇ (Note 3)			−7	mA
I _{OL} (avg)	“L” peak output current S _{OUT}			5.0	mA
f(X _{IN})	Main clock input oscillation frequency (Note 4)		4.0	5.2	MHz
f(S _{CLK})	Serial I/O external clock frequency		250		kHz

Notes 1: The total output current is the sum of all the currents flowing through all the applicable ports. The total average current is an average value measured over 100 ms. The total peak current is the peak value of all the currents.

2: The peak output current is the peak current flowing in each port.

3: The average output current is an average value measured over 100 ms.

4: When the oscillation frequency has a 50 % duty cycle.

ELECTRICAL CHARACTERISTICS ($V_{CC} = 4.0$ to 5.5 V, $T_a = -20$ to 85 °C, unless otherwise noted)

Symbol	Parameter		Test conditions	Limits			Unit
				Min.	Typ.	Max.	
VOH	“H” output voltage	DIG output	$I_{OH} = -18$ mA	$V_{CC}-2.0$			V
		SEG output	$I_{OH} = -7$ mA	$V_{CC}-2.0$			V
VOL	“L” output voltage	SOUT	$I_{OL} = 5$ mA			2.0	V
VT+ — VT–	Hysteresis	SIN, SCLK, CS	$V_{CC} = 5.0$ V		0.5		V
		RESET, XIN			0.5		V
IIH	“H” input voltage	SIN, SCLK, CS	$V_i = V_{CC}$			5.0	μA
		RESET				5.0	μA
		XIN			4.0		μA
IIL	“L” input voltage	SIN, SCLK, CS	$V_i = V_{SS}$			–5.0	μA
		RESET			–150		μA
		XIN			–4.0		μA
ILOAD	Output load current	DIG0 – DIG17 SEG0 – SEG17	$V_{EE} = V_{CC}-36$ V $V_{OL} = V_{CC}$ Output transistors “off”	250	500	750	μA
I _{LEAK}	Output leakage current	DIG0 – DIG17 SEG0 – SEG17	$V_{EE} = V_{CC}-38$ V $V_{OL} = V_{CC}-38$ V Output transistors “off”			–10	μA

ELECTRICAL CHARACTERISTICS ($V_{CC} = 4.0$ to 5.5 V, $T_a = -20$ to 85 °C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
VRAM	RAM hold voltage	When clock is stopped	2.0		5.5	V
ICC	Power source current	$V_{CC} = 5$ V, $f(XIN) = 4.2$ MHz Output transistors “off” at A-D converter operating		0.5	1.0	mA

A-D CONVERTER CHARACTERISTICS ($V_{CC} = 4.0$ to 5.5 V, $T_a = -20$ to 85 °C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
—	Resolution				8	Bits
—	Absolute accuracy (excluding quantization error)	$V_{CC} = 5.12$ V			±3	LSB
T _{conv}	Conversion time				100	tc(XIN)
VIA	Analog input voltage		0		V_{CC}	V
I _{IA}	Analog port input current			0.5	5.0	μA
RLADDER	Ladder resistor			35		kΩ

TIMING REQUIREMENTS ($V_{CC} = 4.0$ to 5.5 V, $T_a = -20$ to 85 °C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min.	Typ.	Max.	
$t_w(\text{RESET})$	Reset input "L" pulse width	2			μs
$t_c(\text{XIN})$	Main clock input cycle time (XIN input)	238			ns
$t_{wH}(\text{XIN})$	Main clock input "H" pulse width	60			ns
$t_{wL}(\text{XIN})$	Main clock input "L" pulse width	60			ns
$t_c(\text{SCLK})$	Serial clock input cycle time (Note)	5			CLKs
$t_{wH}(\text{SCLK})$	Serial clock input "H" pulse width (Note)	2			CLKs
$t_{wL}(\text{SCLK})$	Serial clock input "L" pulse width (Note)	3			CLKs
$t_{su}(\text{SIN-SCLK})$	Serial input setup time (Note)	2			CLKs
$t_h(\text{SCLK-SIN})$	Serial input hold time (Note)	3			CLKs
$t_{su}(\text{CS})$	Serial input setup time	50 $t_c(\text{XIN})$			ns
$t_h(\text{CS})$	Serial input hold time	50 $t_c(\text{XIN})$			ns
$t_{re}(\text{SCLK})$	Serial clock interval time	50 $t_c(\text{XIN})$			ns

Note: The unit means a number of noise filter sampling clock ($2 \times t_c(\text{XIN})$).

SWITCHING CHARACTERISTICS ($V_{CC} = 4.0$ to 5.5 V, $T_a = -20$ to 85 °C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
$t_d(\text{SCLK-SOUT})$	Serial I/O output delay time (Note 1)				3	CLKs
$t_v(\text{SCLK-SOUT})$	Serial I/O output valid time		2		3	CLKs
$t_r(\text{Pch})$	High-breakdown-voltage P-channel open-drain output rising time	$C_L = 100\text{pF}$ $V_{EE} = V_{CC} - 36\text{ V}$		1.8		μs
Cosc	External capacitor size (Note 2)			22		pF

Note 1: The unit means a number of noise filter sampling clock ($2 \times t_c(\text{XIN})$).

2: An external capacitor size varies with a mounted condition.

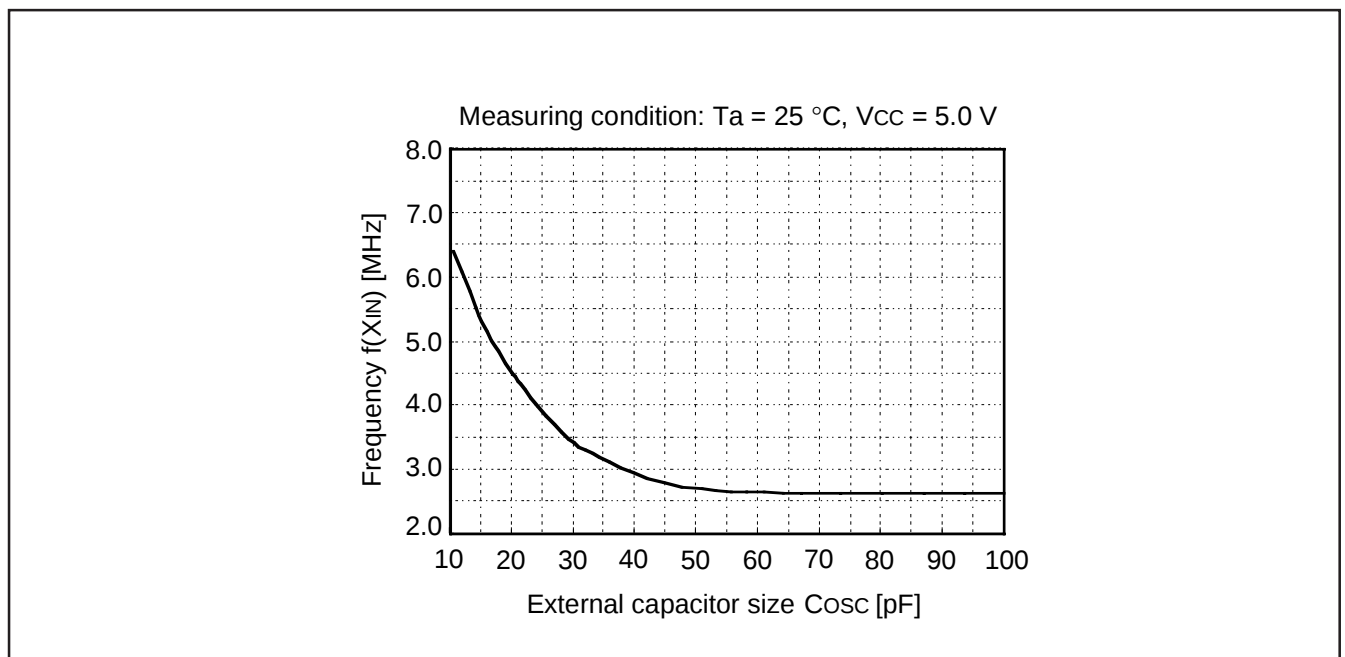


Fig. 13. Standard characteristic example of $f(\text{XIN})$ – C_{osc}

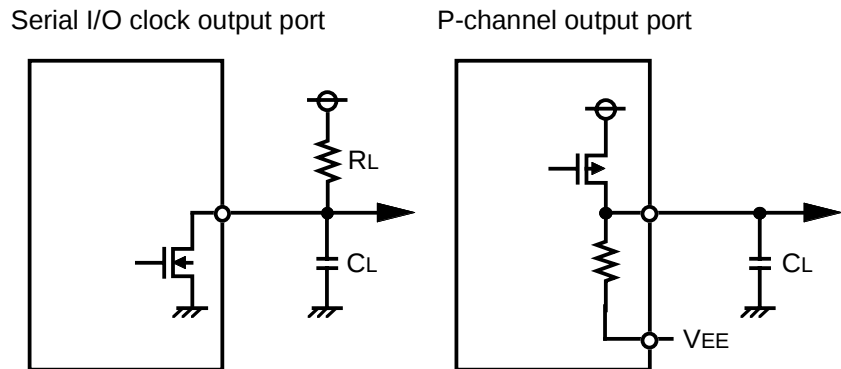


Fig. 14. Output switching characteristics measurement circuit diagram

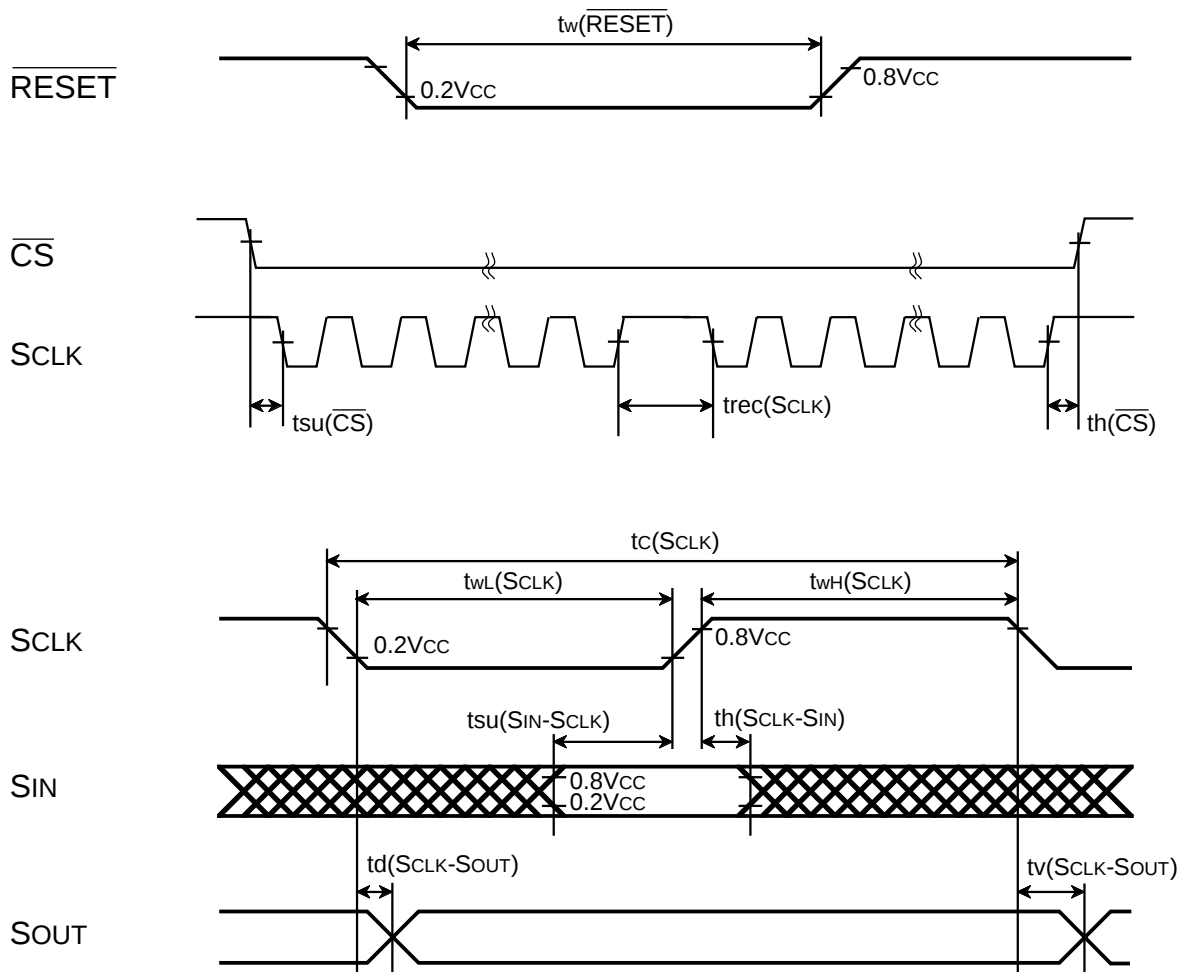


Fig. 15. Timing diagram

M35500AFP/BGP

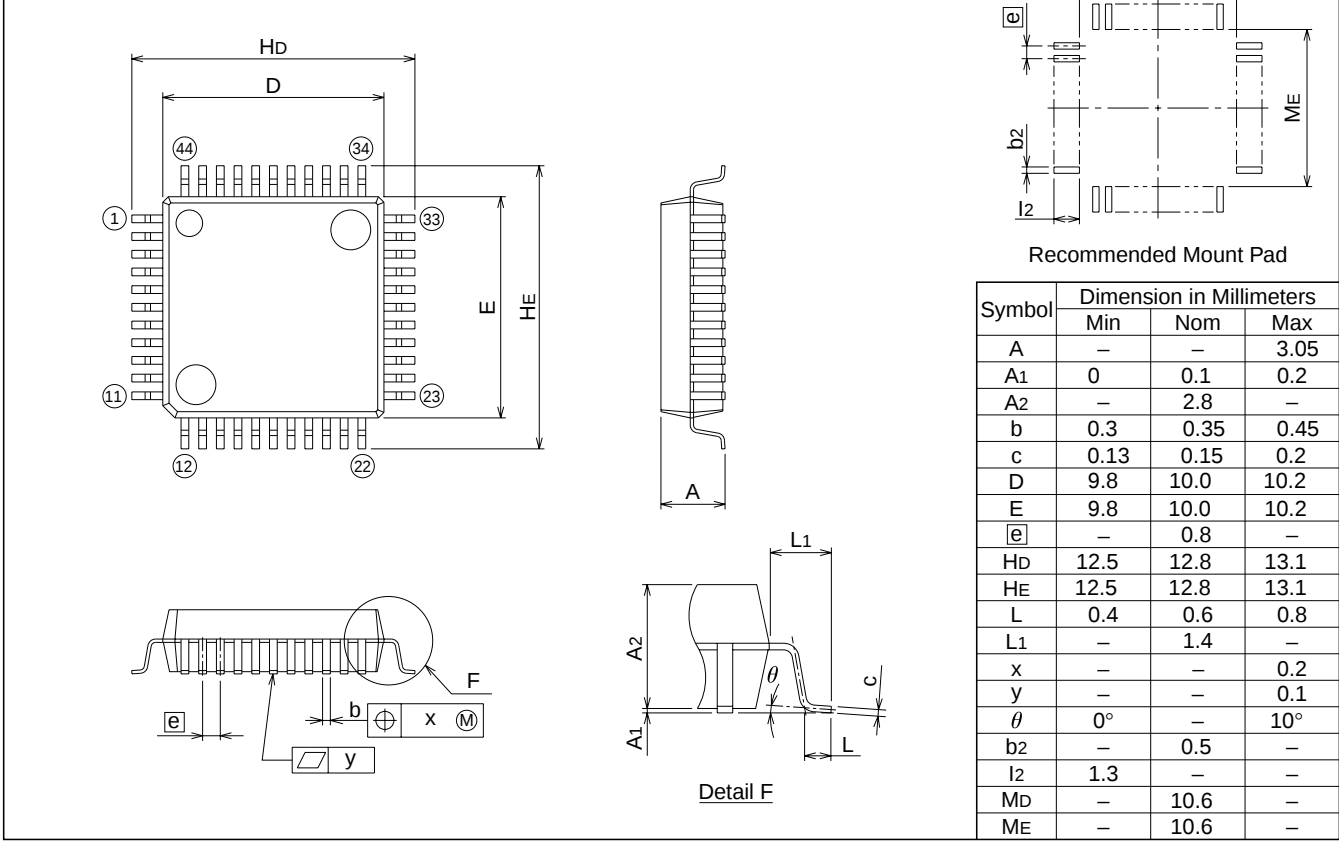
FLD(VFD) CONTROLLER

PACKAGE OUTLINE

44P6N-A

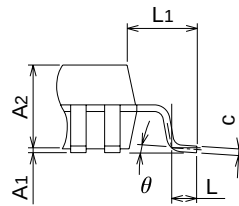
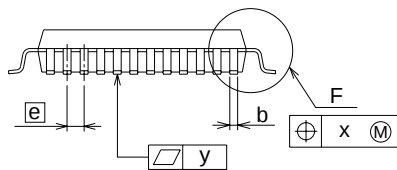
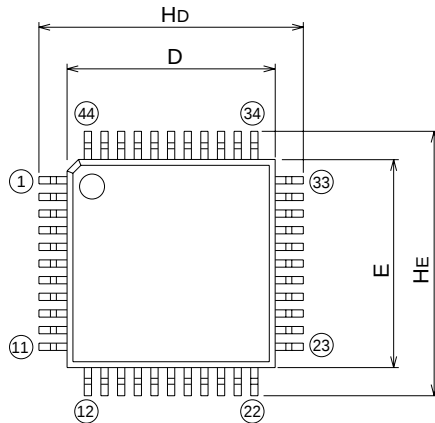
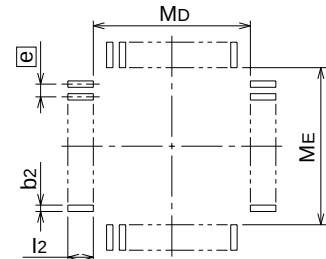
Plastic 44pin 10X10mm body QFP

EIAJ Package Code	JEDEC Code	Weight(g)	Lead Material
QFP44-P-1010-0.80	—	0.59	Alloy 42



44P6X**Plastic 44pin 10X10mm body QFP**

EIAJ Package Code	JEDEC Code	Weight(g)	Lead Material
QFP44-P-1010-0.80	—	—	Cu Alloy

**Detail F****Recommended Mount Pad**

Symbol	Dimension in Millimeters		
	Min	Nom	Max
A	—	—	2.3
A1	0	0.1	0.2
A2	—	2.0	—
b	0.3	0.375	0.45
c	0.15	0.175	0.2
D	9.9	10.0	10.1
E	9.9	10.0	10.1
e	—	0.8	—
Hd	12.5	12.8	13.1
HE	12.5	12.8	13.1
L	0.4	0.6	0.8
L1	—	1.4	—
x	—	—	0.2
y	—	—	0.1
θ	0°	—	10°
b2	—	0.5	—
I2	1.3	—	—
MD	—	10.6	—
ME	—	10.6	—

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REVISION HISTORY	M35500AFP/BGP DATA SHEET
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Rev. No.	Revision Description	Rev. date
1.0	First Edition; As M35500AFP/AGP	11/15/97
2.0	The followings are updated: Product M35500AGP is switched to M35500BGP. Page 1: Oscillating circuit.....<u>RC</u> oscillating... Page 3, Table 1: <u>RC</u> oscillator Page 9: Fig. 11. <u>RC</u> generating circuit Page 12, TIMING REQUIREMENTS: Limits of $t_c(\text{SCLK})$ and $t_{WL}(\text{SCLK})$ Page 12, SWITCHING CHARACTERISTICS: Limits and Unit of $t_v(\text{SCLK-SOUT})$	01/07/00
2.1	Page 15: The 44P6X package outline is added.	03/09/00